

SANYO Semiconductors DATA SHEET

CMOSIC LV5124T— 2-Cell Lithium-Ion Secondary Battery **Protection IC**

Overview

The LV5124T is a protection IC for 2-cell lithium-ion secondary batteries.

Features

• High detection voltage accuracy:

• Monitoring function for each cell: Detects overcharge and over-discharge conditions and controls the

> charging and discharging operation of each cell. Over-charge detection accuracy

Over-discharge detection accuracy ±100mV

The hysteresis of over-discharge detection voltage is made small by

• Hysteresis cancel function: sensing the connection of a load after overcharging has been detected.

• Discharge current monitoring function: Detects over-currents and load shorting, and an excessive

discharge current is controlled.

• Latch function after detecting over-current (Release is made by connecting the charger)

• Low current consumption: Normal operation mode typ. 6.0µA

Stand by mode max. 0.2µA

• 0V cell charging function: Charging is enabled even when the cell voltage is 0V by giving a

potential difference between the V_{DD} pin and V- pin.

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Specifications

Absolute Maximum Ratings at $Ta = 25^{\circ}C$

Parameter		Symbol	Conditions	Ratings	Unit
Power supply voltage		V _{DD}		-0.3 to +12	V
Input voltage Charger minus voltage		V-		V _{DD} -28 to V _{DD} +0.3	
Output voltage	Cout pin voltage	Vcout		V _{DD} -28 to V _{DD} +0.3	V
	Dout pin voltage	Vdout		V _{SS} -0.3 to V _{DD} +0.3	V
Allowable power dissipation		Pd max	Independent IC	170	
Operating ambient temperature		Topr		-30 to +85	°C
Storage temperature		Tstg		-40 to +125	°C

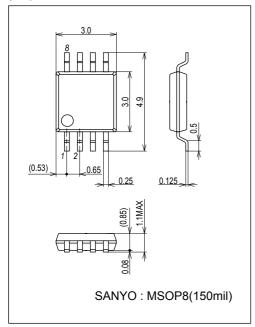
Electrical Characteristics at Ta = 25°C, unless especially specified.

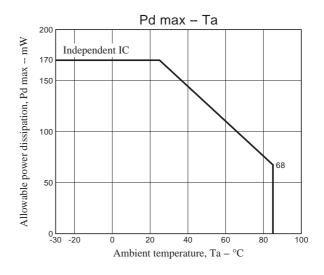
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Parameter	Symbol	Conditions	min	typ	max	Unit
Operation input voltage	Vcell	Between V _{DD} and V _{SS}	1.5		10	V
0V cell charging minimum operation voltage	Vmin	Between V _{DD} -V _{SS} =0 and V _{DD} -V ⁻			1.5	V
Over-charge detection voltage	Vd1		4.325	4.350	4.375	V
Over-charge release voltage	Vr1	V⁻ ≤ Vd3	4.100	4.150	4.200	V
		V- > Vd3	4.250		4.360	V
Over-charge detection delay time	td1	V _{DD} -Vc=3.5V→4.5V, Vc-V _{SS} =3.5V	0.5	1.0	1.5	s
Over-charge release delay time	tr1	V _{DD} -Vc=4.5V→3.5V, Vc-V _{SS} =3.5V	20.0	40.0	60.0	ms
Over-discharge detection voltage	Vd2		2.20	2.30	2.40	V
Over-discharge release hysteresis voltage	Vh2		10.0	20.0	40.0	mV
Over-discharge detection delay time	td2	V _{DD} -Vc=3.5V→2.2V, Vc-V _{SS} =3.5V	50	100	150	ms
Over-discharge release delay time	tr2	V _{DD} -Vc=2.2V→3.5V, Vc-V _{SS} =3.5V	0.5	1.0	1.5	ms
Over-current detection voltage	Vd3	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	0.18	0.20	0.22	٧
Over-current release hysteresis voltage	Vh3	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	5.0	10.0	20.0	mV
Over-current detection delay time	td3	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	2.5	5.0	7.5	ms
Over-current release delay time	tr3	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	0.5	1.0	1.5	ms
Short circuit detection voltage	Vd4	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	1.0	1.3	1.6	٧
Short circuit detection delay time	td4	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	0.2	0.5	0.8	ms
Standby release voltage	Vstb	V _{DD} -Vc=2.0V, Vc-V _{SS} =2.0V (V ⁻)-V _{SS}	V _{DD} ×0.4	V _{DD} ×0.5	V _{DD} ×0.6	V
Internal resistance (connect to V _{DD})	R _{DD}		100	200	400	kΩ
Internal resistance (connect to V _{SS})	R _{SS}		0.5	1.0	1.5	ΜΩ
Cout Nch ON voltage	V _O L1	I _O L=50μA, V _{DD} -Vc=4.4V, Vc-V _{SS} =4.4V			0.5	V
Cout Pch ON voltage	V _O H1	I _O L=50μA, V _{DD} -Vc=3.9V, Vc-V _{SS} =3.9V	V _{DD} -0.5			٧
Dout Nch ON voltage	V _O L2	$I_OL=50\mu A, V_{DD}-Vc=Vd2(min), Vc-V_{SS}=Vd2(min)$			0.5	V
Dout Pch ON voltage	V _O H2	I _O L=50μA, V _{DD} -Vc=3.9V, Vc-V _{SS} =3.9V	V _{DD} -0.5			V
Vc input current	lvc	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V		0.0	1.0	μА
Current consumption	I _{DD}	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V		6.0	13.0	μА
Standby current	Istb	V _{DD} -Vc=2.2V, Vc-V _{SS} =3.5V			0.2	μА
T-terminal input ON voltage	Vtest	V _{DD} -Vc=3.5V, Vc-V _{SS} =3.5V	V _{DD} ×0.4	V _{DD} ×0.5	V _{DD} ×0.6	٧

Package Dimensions

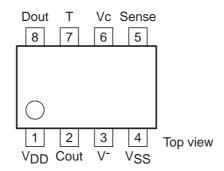
unit: mm (typ)

3245B





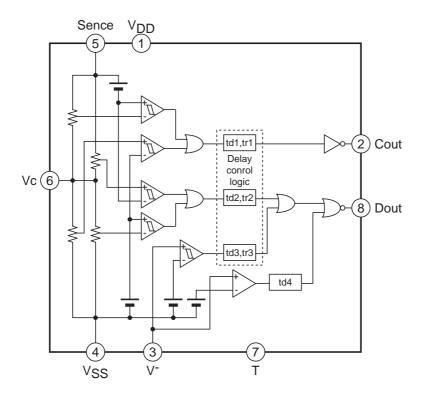
Pin Assignment



Pin Functions

Pin No.	Symbol	Description	
1	V _{DD}	V _{DD} pin	
2	Cout	Overcharge detection output pin	
3	V-	Charger minus voltage input pin	
4	V _{SS}	V _{SS} pin	
5	Sense	Sense pin	
6	Vc	Intermediate voltage input pin	
7	Т	Pin to shorten detection time("H": Shortening mode, "L": Normal mode)	
8	Dout	Overdischarge detection output pin	

Block Diagram



Functional Description

Over-charge detection

If either of the cell voltage is equal to or more than the over-charge detection voltage, stop further charging by turning "L" the Cout pin and turning off external Nch MOS FET after the over-charge detection delay time. This delay time is set by the internal counter.

The over-charge detection comparator has the hysteresis function. Note that this hysteresis can be cancelled by connecting the load after detection of over-charge detection, and it becomes small to hysteresis peculiar to a comparator.

Once over-charge detection is made, over-current detection is not made to prevent incorrect operations. Note that short-circuit can be detected.

Over-charge release

If both cell voltages become equal to or less than the over-charge release voltage ($VM \le Vd3$) when charger is connected, or if it become equal to or less than the over-charge release voltage (VM > Vd3) when load is connected, the Cout pin returns to "H" after the over-charge release delay time set by the internal counter.

When load is connected and either cell or both cell voltages are equal to or more than the over-charge release voltage (VM > Vd3), the Cout pin does not return to "H". But the load current flows through the parasitic diode of external Nch MOS FET on Cout, consequently each cell voltage becomes equal to or less than over-charge release voltage (VM > Vd3), the Cout pin returns to "H" after the over-charge release delay time.

Over-discharge detection

When either cell voltage is equal to or less than over-discharge voltage, the IC stops further discharging by turning the Dout pin "L" and turning off external Nch MOS FET after the over-charge detection delay time.

The IC goes into stand-by mode after detecting over-discharge and its consumption current is kept at about 0A. After over-discharge detection, the V- pin will be connected to V_{DD} pin via internal resistor (typ 200k Ω).

Over-discharge release

Release from over-discharge is made by only connecting charger. If the V- pin voltage becomes equal to or lower than the stand-by release voltage by connecting charger after detecting over-discharge, The IC is released from the stand-by state to start cell voltage monitoring. If both cell voltages become equal to or more than the over-discharge detection voltage by charging, the Dout pin returns to "H" after the over-discharge release delay time set by the internal counter.

Over-current detection

When excessive current flows through the battery, the V- pin voltage rises by the ON resister of external MOS FET and becomes equal to or more than the over-current detection voltage, the Dout pin turns to "L" after the over-current detection delay time and the external Nch MOS FET is turned off to prevent excessive current in the circuit. The detection delay time is set by the internal counter. After detection, the V- pin will be connected to V_{SS} via internal resistor (typ $1M\Omega$). It will not go into stand-by mode after detecting over-current.

Short circuit detection

If greater discharging current flows through the battery and the V- pin voltage becomes equal to or more than the short-circuit detection voltage, it will go into short-circuit detection state after the short circuit delay time shorter than the over-current detection delay time. When short-circuit is detected, just like the time of over-current detection, the Dout pin turns to "L" and external Nch MOS FET is turned off to prevent high current in the circuit. The V- pin will be connected to V_{SS} after detection via internal resistor (typ $1M\Omega$). It will not go into stand-by mode after detecting short circuit.

Over-current/short-detection release

After detecting over-current or short circuit, the internal resistor (typ.1M Ω) between V- pin and VSS pin becomes effective. In this case, the V-pin voltage will be more than over-current detection voltage because of the relation between internal resister and the internal impedance of V- pin. Therefore, if the load resister is removed after detecting over-current or short circuit, the detection state will be kept. Release from over-current or short circuit is only made by connecting a charger to make the V- pins lower than over-current detection voltage and the Dout pin returns to "H after over-current release delay time set by the internal counter.

LV5124T

0V cell charging operation

If voltage between V_{DD} and V becomes equal to or more than the 0V cell charging lowest operation voltage when the cell voltage is 0V, the Cout pin turns to "H" and charging is enabled.

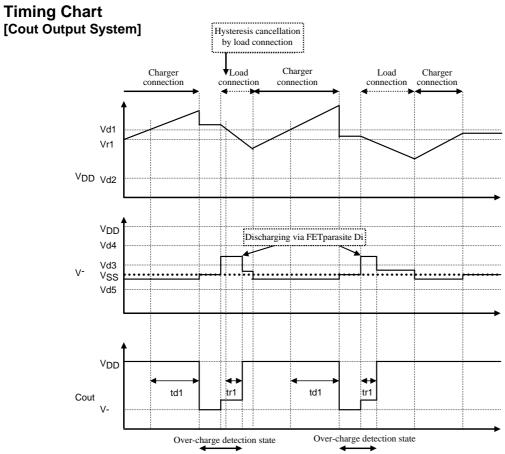
Shorten the test time

By turning T pin to the V_{DD} , the delay times set by the internal counter can be cut. If T pin is open, the delay times are normal. Delay time not set by the counter just like as short circuit detection delay cannot be controlled by this pin And we recommend that T pin is connected to Vss to prevent malfunction when excessive current flows in short circuit operation.

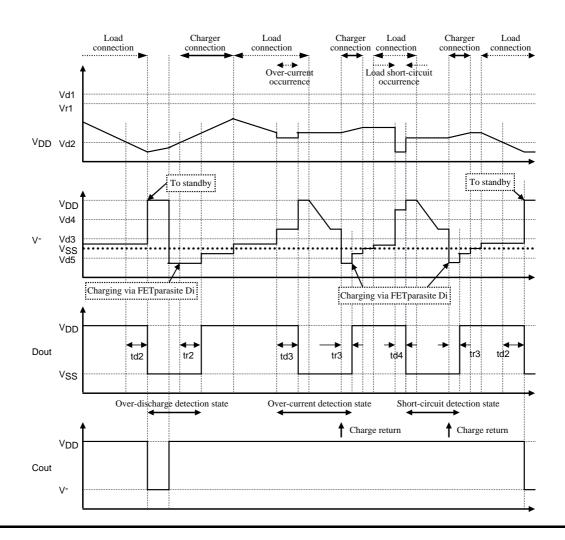
Operation in case of detection overlap

Overlap state		Operation in case of detection overlap	State after detection
During over-charge detection,	Over-discharge detection is made,	Over-charge detection is prioritized. If over- discharge state continues even after over- charge detection, over-discharge detection is resumed.	When over-charge state is made first, V- is released. When over-discharge is detected after over-charge state is made, the IC does not go into the stand-by mode. Note that V- is connected to V_{DD} via $200 k\Omega$.
	Over-current detection is made,	(*1) Both detections can be made in parallel. Over-charge detection continues even when the over-current state is made first. If the over-charge state is made first, over-current detection is interrupted.	(*2) When over-current state is made first, V- is connected to VSS via 1M Ω . When over-charge state is made first, V- is released.
During over-discharge detection,	Over-charge detection is made,	Over-discharge detection is interrupted and over-charge detection is prioritized. When over-discharge state continues even after over-charge state is made, over-discharge detection is resumed.	The IC does not go into the stand-by mode when over-discharge state is made after over-charge detection. Note that V- is connected to V_{DD} via 200k Ω .
	Over-current detection is made,	(*3) Both detections can be made in parallel. Over-discharge detection continues even when the over-current state is made first. But over- current detection is interrupted when the over- discharge state is made first,	(*4) If over-current state is made first, V- will be connected to V _{SS} via 1MΩ. If over-discharge detection is made next, V- also will be connected to V _{DD} via 200kΩ to get into standby mode. If over-discharge state is made first, V- will be connected to V _{DD} via 200kΩ to get into stand-by mode.
During over-current detection,	Over-charge detection is made, Over-discharge detection is made,	(*1) (*3)	(*2) (*4)

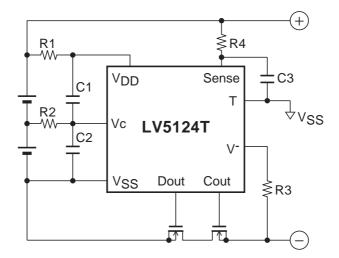
(Note) Short-circuit detection can be made independently.



[Dout Output System]



Application Circuit Example



Components	Recommended value	max	unit
R1, R2	100	1k	Ω
R3	2k	4k	Ω
R4	100	10k	Ω
C1, C2, C3	0.1μ	1μ	F

- * These numbers don't mean to guarantee the characteristic of the IC.
- * In addition to the components in the upper diagram, it is necessary to insert a capacitor with enough capacity between VDD and VSS of the IC as near as possible to stabilize the power supply voltage to the IC.
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